Unit in mm

TOSHIBA TRANSISTOR SILICON NPN EPITAXIAL TYPE

2 S C 2 8 7 8

FOR MUTING AND SWITCHING APPLICATIONS

• High Emitter-Base Voltage: VEBO=25V (Min.)

• High Reverse hFE : Reverse hFE=150 (Typ.)

 $(V_{CE} = -2V, I_{C} = -4mA)$

• Low On Resistance : $R_{ON}=1\Omega$ (Typ.) ($I_B=5mA$)

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Collector-Base Voltage	v_{CBO}	50	V
Collector-Emitter Voltage	v_{CEO}	20	V
Emitter-Base Voltage	$V_{ m EBO}$	25	V
Collector Current	IC	300	mA
Base Current	$I_{\mathbf{B}}$	60	mA
Collector Power Dissipation	PC	400	mW
Junction Temperature	T_{j}	125	°C
Storage Temperature Range	$T_{ m stg}$	-55~125	°C

1. EMITTER 2. COLLECTOR 3. BASE JEDEC TO-92 EIAJ SC-43

2-5F1B

Weight: 0.21g

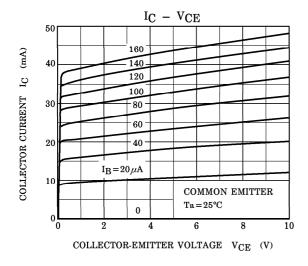
TOSHIBA

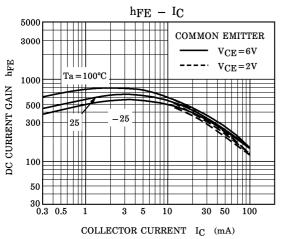
ELECTRICAL CHARACTERISTICS (Ta = 25°C)

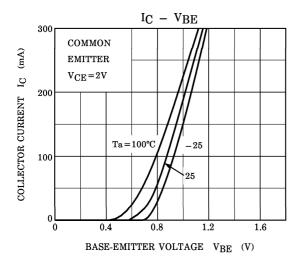
CHARAC	TERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-o	off Current	I_{CBO}	$V_{CB} = 50V$, $I_E = 0$	_	_	0.1	μ A
Emitter Cut-of	f Current	I_{EBO}	$V_{EB} = 25V, I_C = 0$	_	_	0.1	μ A
DC Current G	ain	h _{FE} (Note)	$V_{CE}=2V$, $I_{C}=4mA$	200	_	1200	
Collector-Emit Voltage	ter Saturation	V _{CE} (sat)	$I_C=30$ mA, $I_B=3$ mA	_	0.042	0.1	V
Base-Emitter V	oltage	$ m V_{BE}$	$V_{CE}=2V$, $I_{C}=4mA$	_	0.61	_	V
Transition Frequency		$ m f_{T}$	$V_{CE}=6V, I_{C}=4mA$	_	30	_	MHz
Collector Output Capacitance		C_{ob}	$V_{CB} = 10V, I_{E} = 0, f = 1MHz$	_	4.8	7	pF
Switching Time Sto	Turn-on Time	ton	OUTPUT $4k\Omega$ $10V$ $1\mu s$ V_{BB} V_{CC} $=-3V$ $=12V$ DUTY CYCLE $\leq 2\%$	_	160	_	
	Storage Time	$\mathbf{t}_{ ext{stg}}$			500	_	ns
	Fall Time	tf			130	_	

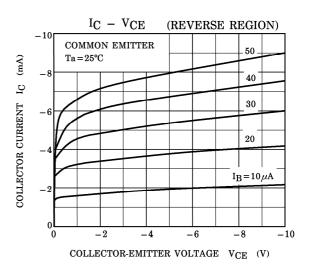
(Note) : hFE Classification $A:200{\sim}700$, $B:350{\sim}1200$

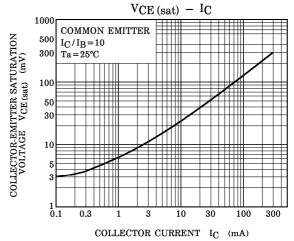
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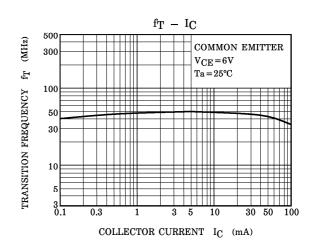




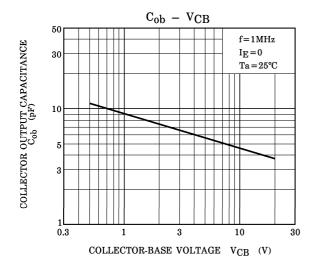


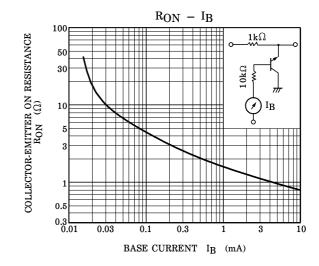


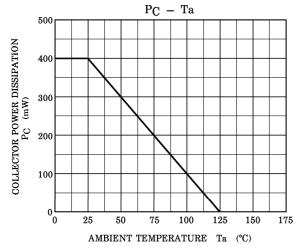




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4 2001-05-31

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